

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

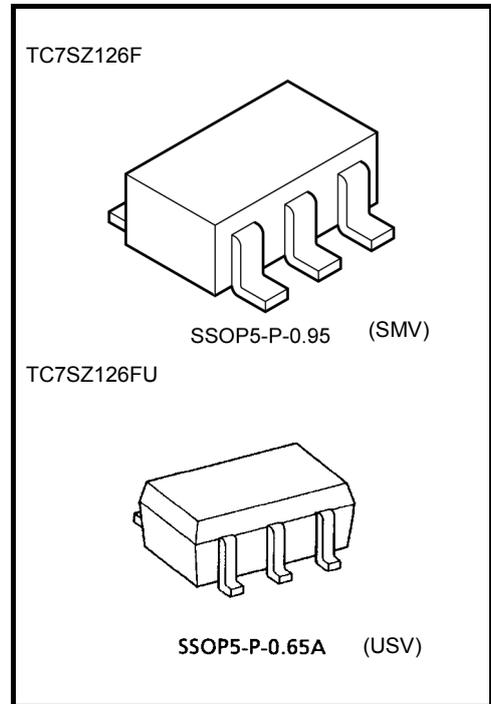
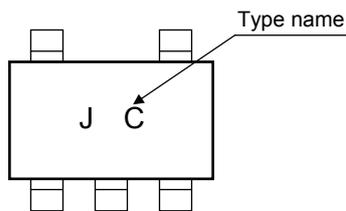
TC7SZ126F, TC7SZ126FU

Bus Buffer 3-State Output

Features

- High output drive: ± 24 mA (min) @ $V_{CC} = 3$ V
- Super high speed operation:
 t_{pd} 2.6 ns (typ.) @ $V_{CC} = 5$ V, 50 pF
- Operation voltage range: $V_{CC(opr)} = 1.8 \sim 5.5$ V
- Power down protection is provided on all inputs and outputs.
- Matches the performance of TC74LCX series when operated at 3.3 V V_{CC} .

Marking

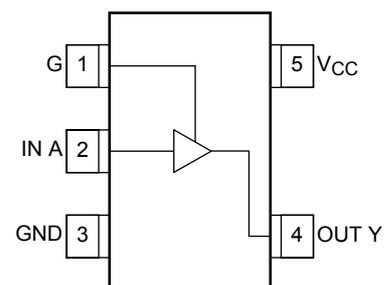


Weight
 SSOP5-P-0.95 : 0.016 g (typ.)
 SSOP5-P-0.65A : 0.006 g (typ.)

Absolute Maximum Ratings (Ta = 25°C)

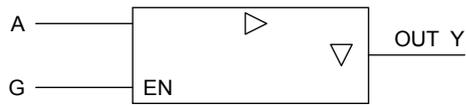
Characteristics	Symbol	Rating	Unit
Power supply voltage	V_{CC}	-0.5~6	V
DC input voltage	V_{IN}	-0.5~6	V
DC output voltage	V_{OUT}	-0.5~6	V
Input diode current	I_{IK}	± 20	mA
Output diode current	I_{OK}	± 20	mA
DC output current	I_{OUT}	± 50	mA
DC V_{CC} /ground current	I_{CC}	± 50	mA
Power dissipation	P_D	200	mW
Storage temperature	T_{stg}	-65~150	°C
Lead temperature (10s)	T_L	260	°C

Pin Assignment (top view)



Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.
 Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Logic Diagram



Truth Table

Input		Output
A	G	Y
X	L	Z
L	H	L
H	H	H

X: Don't Care
Z: High Impedance

Operating Ranges

Characteristics	Symbol	Rating	Unit
Supply voltage	V_{CC}	1.8~5.5	V
		1.5~5.5 (Note 1)	
Input voltage	V_{IN}	0~5.5	V
Output voltage	V_{OUT}	0~5.5 (Note 2)	V
		0~ V_{CC} (Note 3)	
Operating temperature	T_{opr}	-40~85	°C
Input rise and fall time	dt/dv	0~20 ($V_{CC} = 1.8\text{ V}, 2.5\text{ V} \pm 0.2\text{ V}$)	ns/V
		0~10 ($V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$)	
		0~5 ($V_{CC} = 5.5\text{ V} \pm 0.5\text{ V}$)	

Note 1: Data retention only

Note 2: $V_{CC} = 0\text{ V}$

Note 3: H and Low state

Electrical Characteristics

DC Characteristics

Characteristics		Symbol	Test Condition	Ta = 25°C			Ta = -40~85°C		Unit			
				V _{CC} (V)	Min	Typ.	Max	Min		Max		
Input voltage	High level	V _{IH}	—	1.8	0.88 × V _{CC}	—	—	0.88 × V _{CC}	—	V		
				2.3~5.5	0.75 × V _{CC}	—	—	0.75 × V _{CC}	—			
	Low level	V _{IL}		1.8	—	—	0.12 × V _{CC}	—	0.12 × V _{CC}			
				2.3~5.5	—	—	0.25 × V _{CC}	—	0.25 × V _{CC}			
Output voltage	High level	V _{OH}	V _{IN} = V _{IH}	I _{OH} = -100 μA	1.8	1.7	1.8	—	1.7	—	V	
					2.3	2.2	2.3	—	2.2	—		
					3.0	2.9	3.0	—	2.9	—		
					4.5	4.4	4.5	—	4.4	—		
				I _{OH} = -8 mA	2.3	1.9	2.15	—	1.9	—		
					I _{OH} = -16 mA	3.0	2.4	2.8	—	2.4		—
					I _{OH} = -24 mA	3.0	2.3	2.68	—	2.3		—
					I _{OH} = -32 mA	4.5	3.8	4.2	—	3.8		—
	Low level	V _{OL}	V _{IN} = V _{IL}	I _{OL} = 100 μA	1.8	—	0	0.1	—	0.1		
					2.3	—	0	0.1	—	0.1		
					3.0	—	0	0.1	—	0.1		
					4.5	—	0	0.1	—	0.1		
				I _{OL} = 8 mA	2.3	—	0.1	0.3	—	0.3		
					I _{OL} = 16 mA	3.0	—	0.15	0.4	—		0.4
I _{OL} = 24 mA					3.0	—	0.22	0.55	—	0.55		
I _{OL} = 32 mA					4.5	—	0.22	0.55	—	0.55		
Input leakage current		I _{IN}	V _{IN} = 5.5 V or GND	0~5.5	—	—	±1	—	±10	μA		
3-state output off-state current		I _{OZ}	V _{IN} = V _{IH} or V _{IL} V _{OUT} = 0~5.5 V	1.8~5.5	—	—	±1	—	±10	μA		
Power off leakage current		I _{OFF}	V _{IN} or V _{OUT} = 5.5 V	0.0	—	—	1	—	10	μA		
Quiescent supply current		I _{CC}	V _{IN} = V _{CC} or GND	5.5	—	—	2	—	20	μA		

AC Characteristics (unless otherwise specified, Input: $t_r = t_f = 3$ ns)

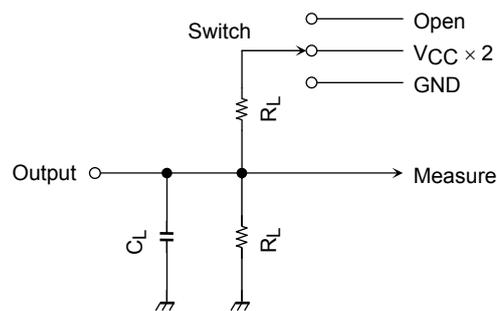
Characteristics	Symbol	Test Condition	Ta = 25°C			Ta = -40~85°C		Unit		
			VCC (V)	Min	Typ.	Max	Min		Max	
Propagation delay time	t_{pLH}	$C_L = 15$ pF, $R_L = 1$ M Ω	1.8	2.0	5.3	11.0	2.0	11.5	ns	
			2.5 ± 0.2	0.8	3.4	7.5	0.8	8.0		
	t_{pHL}		3.3 ± 0.3	0.5	2.5	5.2	0.5	5.5		
			5.0 ± 0.5	0.5	2.1	4.5	0.5	4.8		
			$C_L = 50$ pF, $R_L = 500$ Ω	3.3 ± 0.3	1.5	3.2	5.7	1.5		6.0
				5.0 ± 0.5	0.8	2.6	5.0	0.8		5.3
Output enable time	t_{pZL}	$C_L = 50$ pF, $R_L = 500$ Ω	1.8	2.0	6.1	11.5	2.0	12.0	ns	
			2.5 ± 0.2	1.5	3.8	8.0	1.5	8.5		
	t_{pZH}		3.3 ± 0.3	1.5	3.2	5.7	1.5	6.0		
			5.0 ± 0.5	0.8	2.3	5.0	0.8	5.3		
Output disable time	t_{pLZ}	$C_L = 50$ pF, $R_L = 500$ Ω	1.8	2.0	5.0	11.0	2.0	12.0	ns	
			2.5 ± 0.2	1.0	4.0	8.0	1.5	8.5		
	t_{pHZ}		3.3 ± 0.3	1.0	3.5	5.7	1.0	6.0		
			5.0 ± 0.5	0.5	2.5	4.7	0.5	5.0		
Input capacitance	C_{IN}	—	0~5.5	—	4	—	—	pF		
Power dissipation capacitance	C_{PD}	(Note 4)	3.3	—	17	—	—	—	pF	
			5.5	—	24	—	—	—		

Note 4: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

AC Characteristics Measurement Circuit

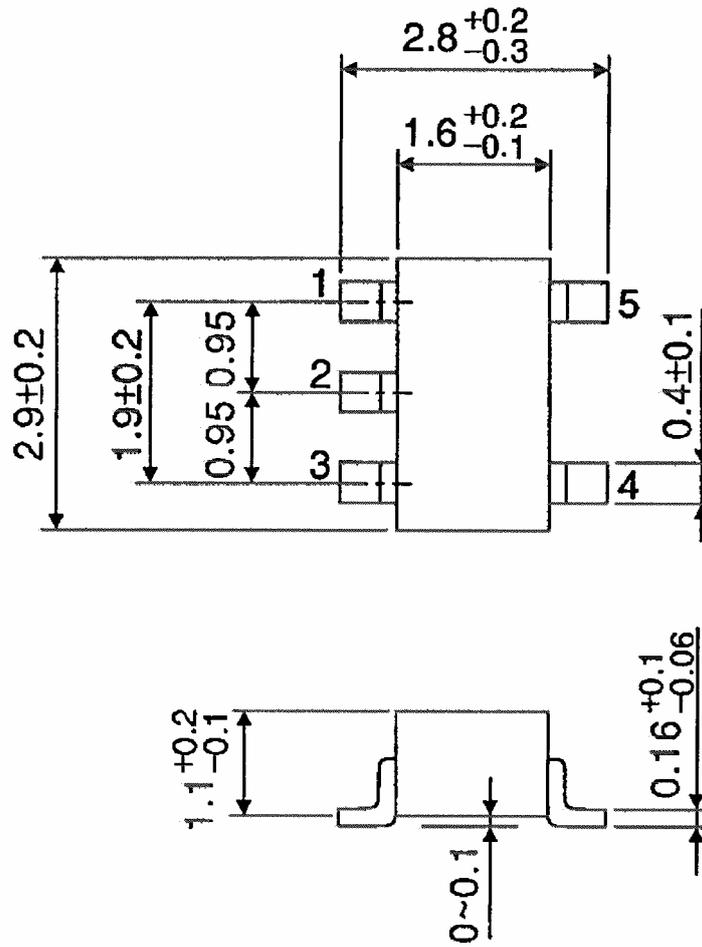


Characteristics	Switch
t_{pLH} , t_{pHL}	Open
t_{pLZ} , t_{pZL}	$V_{CC} \times 2$
t_{pHZ} , t_{pZH}	GND

Package Dimensions

SSOP5-P-0.95

Unit : mm

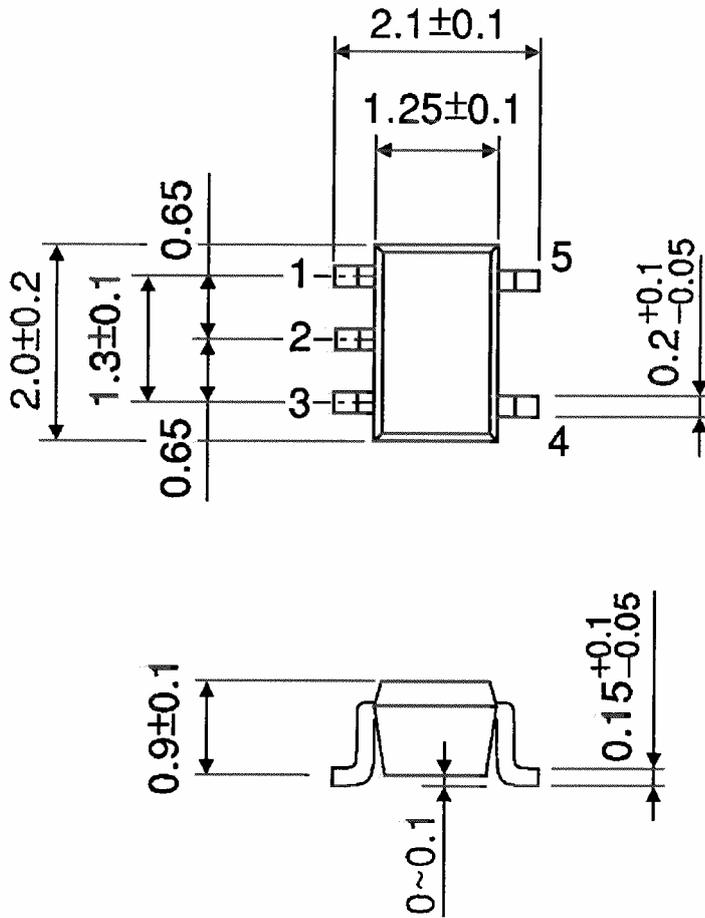


Weight: 0.016 g (typ.)

Package Dimensions

SSOP5-P-0.65A

Unit : mm



Weight: 0.006 g (typ.)

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20070701-EN GENERAL

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